N-channel LFPAK 100V 27.5 mΩ standard level MOSFET

Rev. 02 — 30 March 2010

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel MOSFET in LFPAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- Advanced TrenchMOS provides low RDSon and low gate charge
- High efficiency gains in switching power converters

1.3 Applications

- DC-to-DC converters
- Lithium-ion battery protection
- Load switching

1.4 Quick reference data

Table 1. Quick reference

- Improved mechanical and thermal characteristics
- LFPAK provides maximum power density in a Power SO8 package
- Motor control
- Server power supplies

| Table 1. | QUICK reference | | | | | |
|----------------------|--|--|-----|------|-----|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| V _{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | - | - | 100 | V |
| I _D | drain current | T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 1</u> | - | - | 42 | A |
| P _{tot} | total power dissipation | $T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 2}{\text{Figure } 2}$ | - | - | 89 | W |
| Tj | junction temperature | | -55 | - | 175 | °C |
| Avalance | he ruggedness | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | | - | - | 68 | mJ |
| Dynamic | characteristics | | | | | |
| Q_{GD} | gate-drain charge | V _{GS} = 10 V; I _D = 15 A; | - | 10.3 | - | nC |
| Q _{G(tot)} | total gate charge | $V_{DS} = 50 \text{ V}; \text{ see } \frac{\text{Figure } 15}{\text{and } \frac{16}{2}}$ | - | 33 | - | nC |



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| Table 1. | Quick reference | .continued | | | | |
|------------|-------------------------------------|---|-----|------|------|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| Static c | haracteristics | | | | | |
| R_{DSon} | drain-source on-state resistance | V_{GS} = 10 V; I _D = 15 A; T _j = 100 °C; see <u>Figure 13</u> | - | - | 52 | mΩ |
| | | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 14}{100000000000000000000000000000000000$ | - | 21.4 | 27.5 | mΩ |

2. Pinning information

| Table 2. | Pinning | information | | |
|----------|---------|-----------------------------------|---|----------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | S | source | | |
| 2 | S | source | mb | |
| 3 | S | source | | |
| 4 | G | gate | ٩, | |
| mb | D | mounting base; connected to drain | $\begin{array}{c} \hline \\ \hline \\ 1 \end{array} \begin{array}{c} 2 \end{array} \begin{array}{c} 3 \end{array} \begin{array}{c} 4 \end{array}$ | mbb076 S |
| | | | SOT669 (LFPAK) | |

3. Ordering information

| Table 3. Ordering information | | | | | | |
|-------------------------------|---------|---|---------|--|--|--|
| Type number | Package | | | | | |
| | Name | Description | Version | | | |
| PSMN028-100YS | LFPAK | plastic single-ended surface-mounted package (LFPAK); 4 leads | SOT669 | | | |

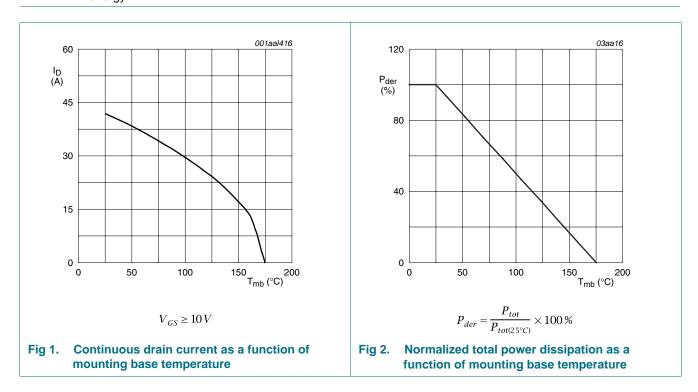
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4. Limiting values

Table 4. Limiting values

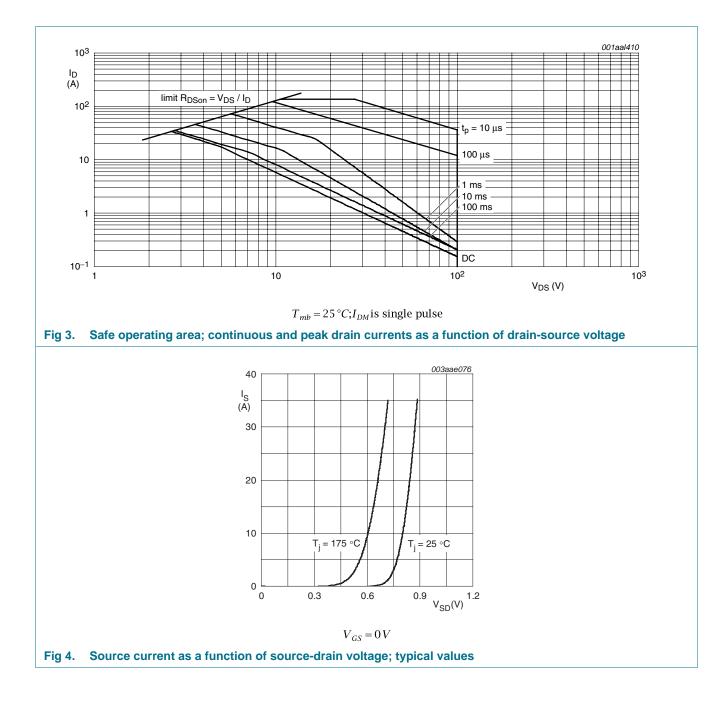
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Cumpheal | Devenueter | Conditions | N/1:0 | Max | 11 |
|----------------------|--|--|-------|-----|------|
| Symbol | Parameter | Conditions | Min | Max | Unit |
| V _{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C | - | 100 | V |
| V _{DGR} | drain-gate voltage | T _j ≤ 175 °C; T _j ≥ 25 °C; R _{GS} = 20 kΩ | - | 100 | V |
| V _{GS} | gate-source voltage | | -20 | 20 | V |
| I _D | drain current | V _{GS} = 10 V; T _{mb} = 100 °C; see <u>Figure 1</u> | - | 30 | А |
| | | V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> | - | 42 | А |
| I _{DM} | peak drain current | $t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3 | - | 137 | А |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | - | 89 | W |
| T _{stg} | storage temperature | | -55 | 175 | °C |
| Tj | junction temperature | | -55 | 175 | °C |
| T _{sld(M)} | peak soldering temperature | | - | 260 | °C |
| Source-dra | ain diode | | | | |
| I _S | source current | T _{mb} = 25 °C; see <u>Figure 4</u> | - | 42 | А |
| I _{SM} | peak source current | $t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$ | - | 137 | А |
| Avalanche | ruggedness | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 34 A; V_{sup} ≤ 100 V; unclamped; R_{GS} = 50 Ω | - | 68 | mJ |



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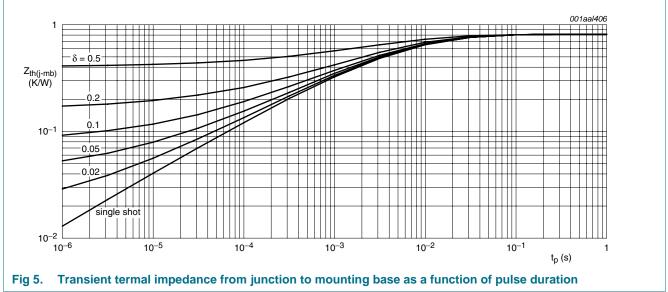
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Thermal characteristics 5.

| Table 5. | Thermal characteristics | | | | | |
|-----------------------|---|--------------|-----|------|------|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| R _{th(j-mb)} | thermal resistance from junction to mounting base | see Figure 5 | - | 0.81 | 1.68 | K/W |
| | | | | | | |



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6. Characteristics

| Table 6. | Characteristics | | | | | |
|------------------------|---|---|------|------|------|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| Static cha | racteristics | | | | | |
| V _{(BR)DSS} | drain-source | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$ | 90 | - | - | V |
| | breakdown voltage | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | 100 | - | - | V |
| V _{GS(th)} | gate-source threshold | I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; see <u>Figure 11</u> | 1 | - | - | V |
| voltage | | I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; see <u>Figure 12</u> and <u>11</u> | 2 | 3 | 4 | V |
| | | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; \text{ see } Figure 11$ | - | - | 4.7 | V |
| I _{DSS} | drain leakage current | V_{DS} = 100 V; V_{GS} = 0 V; T_j = 125 °C | - | - | 50 | μA |
| | | V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25 °C | - | 0.02 | 2 | μA |
| I _{GSS} | gate leakage current | $V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 2 | 100 | nA |
| | | V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C | - | 2 | 100 | nA |
| R _{DSon} | drain-source on-state resistance | V _{GS} = 10 V; I _D = 15 A; T _j = 100 °C; see <u>Figure 13</u> | - | - | 52 | mΩ |
| | V _{GS} = 10 V; I _D = 15 A; T _j = 175 °C; see <u>Figure 13</u> | - | 49.9 | 74.3 | mΩ | |
| | | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 14</u> | - | 21.4 | 27.5 | mΩ |
| R _G | internal gate resistance (AC) | f = 1 MHz | - | 0.5 | 1.5 | Ω |
| Dynamic | characteristics | | | | | |
| Q _{G(tot)} | total gate charge | I_D = 15 A; V_{DS} = 50 V; V_{GS} = 10 V; see Figure 15 and $\underline{16}$ | - | 33 | - | nC |
| | | $I_D = 0 \text{ A}; V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}$ | - | 25 | - | nC |
| Q _{GS} | gate-source charge | I_D = 15 A; V_{DS} = 50 V; V_{GS} = 10 V; see Figure 15 and $\underline{16}$ | - | 7.2 | - | nC |
| Q _{GS(th)} | pre-threshold gate-source charge | I_D = 15 A; V_{DS} = 50 V; V_{GS} = 10 V; see <u>Figure 15</u> | - | 5 | - | nC |
| Q _{GS(th-pl)} | post-threshold gate-source charge | | - | 2.2 | - | nC |
| Q _{GD} | gate-drain charge | I_D = 15 A; V_{DS} = 50 V; V_{GS} = 10 V; see $\underline{Figure\ 15}$ and $\underline{16}$ | - | 10.3 | - | nC |
| V _{GS(pl)} | gate-source plateau voltage | $V_{DS} = 50 \text{ V}; \text{ see } \frac{\text{Figure } 15}{15} \text{ and } \frac{16}{15}$ | - | 4.1 | - | V |
| C _{iss} | input capacitance | $V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25 \text{ °C};$ | - | 1634 | - | pF |
| C _{oss} | output capacitance | see Figure 17 | - | 132 | - | pF |
| C _{rss} | reverse transfer capacitance | | - | 85 | - | pF |
| t _{d(on)} | turn-on delay time | $V_{DS} = 50 \text{ V}; \text{ R}_{L} = 3.3 \Omega; \text{ V}_{GS} = 10 \text{ V};$ | - | 15 | - | ns |
| t _r | rise time | $R_{G(ext)} = 4.7 \ \Omega; T_j = 25 \ ^{\circ}C$ | - | 14 | - | ns |
| t _{d(off)} | turn-off delay time | | - | 33 | - | ns |
| t _f | fall time | | - | 12 | - | ns |

Source-drain diode

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Symbol

 V_{SD}

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Max

1.2

Unit

V

Тур

0.8

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Min

-

| | reverse recovery time | $I_{S} = 5 \text{ A}; \text{ d}I_{S}/\text{d}t = 100 \text{ A}$ | õs; V _{GS} = 0 V; | - | 48.7 - | ns |
|---|---|---|---|-----------------------------------|--|------|
| | recovered charge | V _{DS} = 50 V | | - | 95.7 - | nC |
| | | 003aae070 | | | 003aae069 | |
| 60 | | | 40 | | | |
| g _{fs} (S) | | | I _D (A) | | | |
| (0) | | | 30 | | | |
| 40 | | | | | | |
| - | | | | | | |
| + | | | 20 | | | |
| F | | | | | | |
| 20 | | | 10 | | | |
| | | | 10 | T _i = 175 ∘C | T _j = 25 °C | |
| | | | | | | |
| ₀ لا | | | 0 | | | |
| 0 | 10 20 | 30 40 I _D (A) | 0 | 2 | 4 V _{GS} (V) 6 | |
| | orward transconductar ain current; typical val | | | | DSon S: drain current a voltage; typical | |
| dr | orward transconductar | nce as a function of | function o | characteristic | s: drain current a | |
| | orward transconductar | 003aae071 | 45 | characteristic | s: drain current a voltage; typical | |
| dr 3000 C | orward transconductar | nce as a function of lues | 45 R _{DSon} | characteristic | s: drain current a voltage; typical | |
| dr 3000 | orward transconductar | 003aae071 | 45 | characteristic | s: drain current a voltage; typical | |
| dr 3000 C | orward transconductar | 003aae071 | 45 R _{DSon} | characteristic | s: drain current a voltage; typical | |
| 3000 C (pF) | orward transconductar | 003eae071 | 45 R _{DSon} (mΩ) | characteristic | s: drain current a voltage; typical | |
| 3000 C (pF) | orward transconductar | 003aae071 | 45 R _{DSon} (mΩ) | characteristic | s: drain current a voltage; typical | |
| dr 3000 C (pF) 2000 | orward transconductar | 003eae071 | 45 R _{DSon} (mΩ) 35 | characteristic | s: drain current a voltage; typical | |
| 3000 C (pF) | orward transconductar | 003eae071 | 45 R _{DSon} (mΩ) | characteristic | s: drain current a voltage; typical | |
| dr 3000 C (pF) 2000 | orward transconductar | 003eae071 | 45 R _{DSon} (mΩ) 35 | characteristic | s: drain current a voltage; typical | |
| dr 3000 C (pF) 2000 | orward transconductar | 003eae071 | 45 R _{DSon} (mΩ) 35 | characteristic | s: drain current a voltage; typical | |
| dr 3000 C (pF) 2000 | prward transconductar ain current; typical val | 003aae071 | 45 R _{DSon} (mΩ) 35 | characteristic | s: drain current a voltage; typical | valu |
| dr 3000 C (pF) 2000 1000 | brward transconductar ain current; typical val | 003aae071 | function c 45 R _{DSon} (mΩ) 35 25 15 | characteristic: of gate-source | ^{003aae074} 003aae074 | valu |

 $I_S = 15 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 4}}{1000 \text{ C}}$

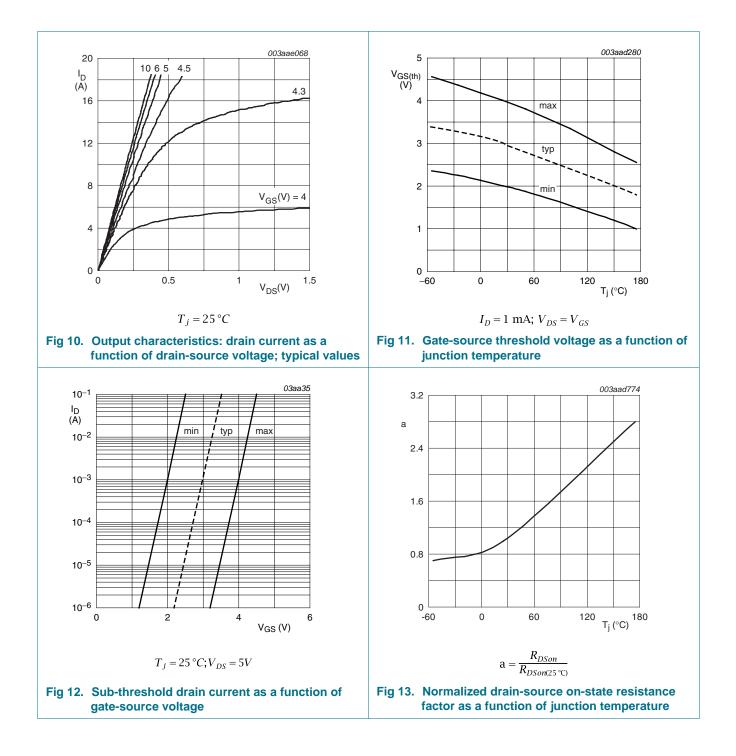
Table 6. Characteristics ... continued Parameter

source-drain voltage

Conditions

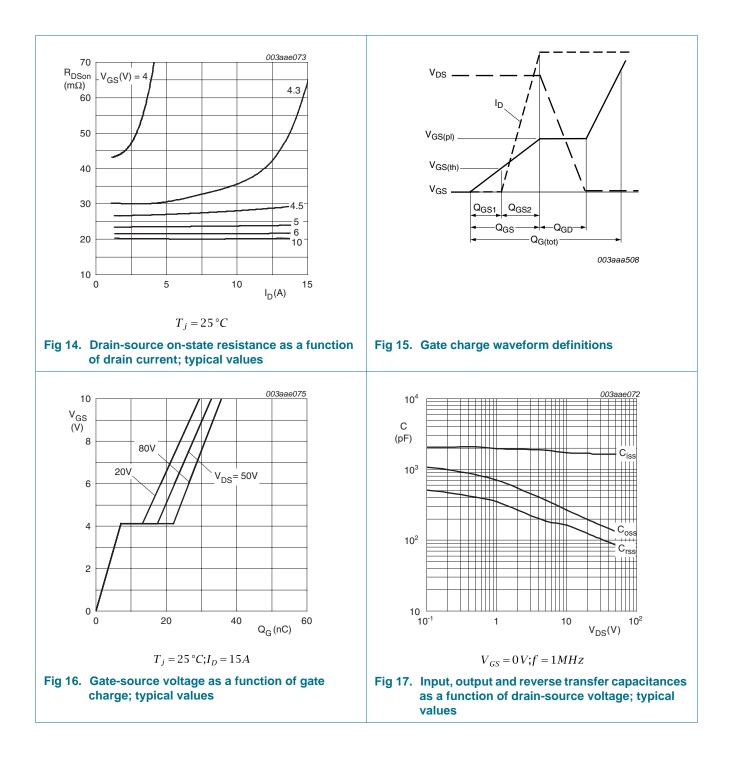
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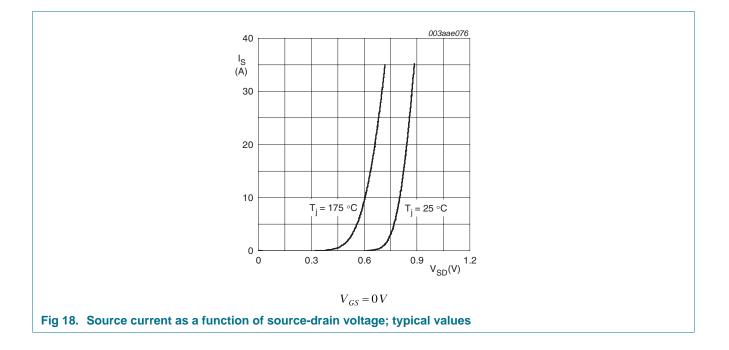
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7. Package outline

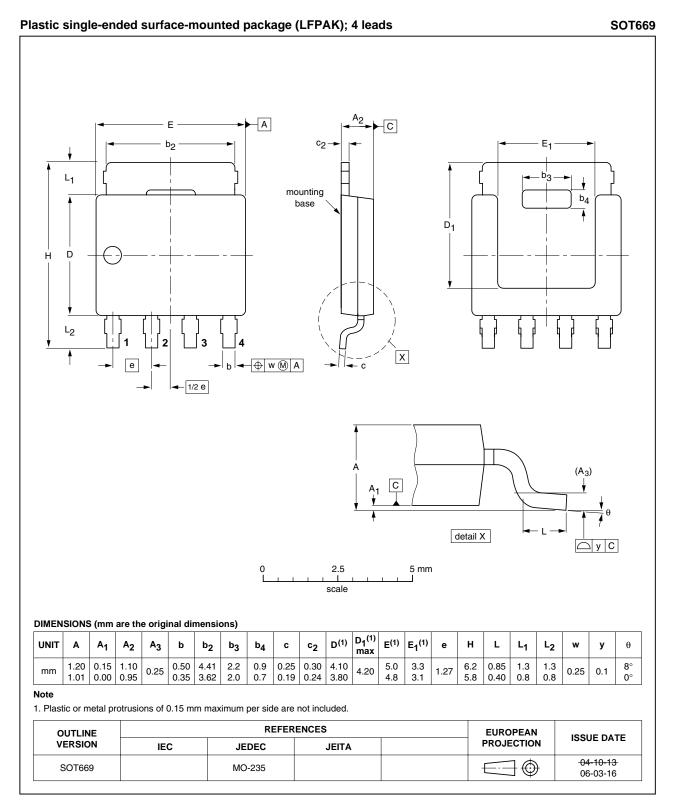


Fig 19. Package outline SOT669 (LFPAK)

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8. Revision history

| Table 7. Revision his | story | | | |
|-----------------------|----------------------------------|---------------------------|---------------|-----------------|
| Document ID | Release date | Data sheet status | Change notice | Supersedes |
| PSMN028-100YS_2 | 20100330 | Product data sheet | - | PSMN028-100YS_1 |
| Modifications: | Status chail | nged from objective to pr | oduct. | |
| | Various cha | anges to content. | | |
| PSMN028-100YS_1 | 20100210 | Objective data sheet | - | - |

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9. Legal information

9.1 Data sheet status

| Document status [1][2] | Product status ^[3] | Definition |
|--------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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